



Edw 2877
#7/IDS
Supp
11/29/99

RECEIVED

NOV 23 1999

TECHNOLOGY CENTER 2800

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Leonard H. Bieman

Title: SCANNING PHASE MEASURING METHOD AND SYSTEM FOR AN OBJECT AT A VISION STATION

Docket No.: 139.045USR

Serial No.: 09/111,978

Filed: July 8, 1998

Due Date: November 30, 1999

Examiner: Hoa Q. Pham

Group Art Unit: 2877

Assistant Commissioner for Patents
Washington, D.C. 20231

We are transmitting herewith the following attached items (as indicated with an "X"):

A return postcard.
 A Supplemental Information Disclosure Statement (2 pgs.), Form 1449 (1 pg.), and copies of 8 cited references.
 International Search Reports PCT/US 99/15411 and PCT/US 99/15412 (2 pgs each.).

Please consider this a PETITION FOR EXTENSION OF TIME for sufficient number of months to enter these papers and please charge any additional required fees or credit overpayment to Deposit Account No. 19-0743.

CERTIFICATE UNDER 37 CFR 1.8: The undersigned hereby certifies that this Transmittal Letter and the paper, as described above, are being deposited in the United States Postal Service, as first class mail, in an envelope addressed to: Assistant Commissioner for Patents, Washington, D.C. 20231, on this 19 day of November, 1999.

SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A.
P.O. Box 2938, Minneapolis, MN 55402 (612-373-6900)

By: Charles A. Lemaire

Atty: Charles A. Lemaire
Reg. No. 36,198

Customer Number 21186

(GENERAL)



S/N 09/111,978

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Leonard H. Bieman

Examiner: Hoa Q. Pham

Serial No.: 09/111,978

Group Art Unit: 2877

Filed: July 8, 1998

Docket: 139.045USR

Title: SCANNING PHASE MEASURING METHOD AND SYSTEM FOR AN
OBJECT AT A VISION STATION

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT RECEIVED
AND CERTIFICATION UNDER 1.97(e)(1)

NOV 23 1999

Assistant Commissioner for Patents

TECHNOLOGY CENTER 2800

Washington, D.C. 20231

In compliance with the duty imposed by 37 C.F.R. § 1.56, and in accordance with 37 C.F.R. §§ 1.97 *et. seq.*, the enclosed materials are brought to the attention of the Examiner for review in connection with the above-identified patent application. Pursuant to the provisions of MPEP 609, Applicant requests that a copy of the 1449 form, marked as being considered and initialled by the Examiner, be returned with the next official communication.

The attached references were discovered as a result of Search Reports in related copending foreign patent applications. Enclosed for the Examiner's information are copies of the documents and the International Search Reports.

CERTIFICATION UNDER 37 C.F.R. § 1.97(e)(1)

The undersigned attorney hereby certifies that each item of information contained in this Supplemental Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Serial Number: 09/111,978

Filing Date: July 8, 1998

Title: SCANNING PHASE MEASURING METHOD AND SYSTEM FOR AN OBJECT AT A VISION STATION

Page 2

Dkt: 139.045USR

Applicant respectfully request consideration of these references during prosecution of the above-identified matter. The Examiner is invited to contact the Applicant's Representatives at the below-listed telephone number if there are any questions regarding this communication.

Respectfully submitted,

LEONARD H. BIEMAN

By his Representatives,

SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A.

P.O. Box 2938

Minneapolis, MN 55402

(612) 373-6949

Date 19 November 1999

CAL/maf

By Charles A. Lemaire

Charles A. Lemaire

Reg. No. 36,198

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to Assistant Commissioner of Patents, Washington, D.C. 20231 on November 19, 1999.

Name

Charles A. Lemaire

Signature

Charles A. Lemaire